## Application/Control No. Applicant(s)/Patent Under Reexamination 09/467,221 OKAUE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ahshik Kim 2876 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY US-6,616,053 09-2003 Kondo et al. 235/492 \* US-6,170,743 01-2001 235/380 В Okaue et al. С US-US-D Ε US-F US-US-G Н US-1 US-J US-Κ US-L US-М US-**FOREIGN PATENT DOCUMENTS** Date Document Number \* Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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